

SLOVENSKI STANDARD oSIST prEN IEC 60688:2021

01-april-2021

Električni merilni pretvorniki za pretvarjanje izmeničnih in enosmernih električnih veličin v analogne ali digitalne signale

Electrical measuring transducers for converting AC and DC electrical quantities to analogue or digital signals

iTeh STANDARD PREVIEW

Transducteurs électriques de mesure convertissant les grandeurs électriques alternatives ou continues en signaux analogiques ou numériques

oSIST prEN IEC 60688:2021

Ta slovenski standard je istoveten zalog/starpreniec-60688:2021 15bc-d59944c954f7/osist-preniec-60688-2021

ICS:

17.220.20 Merjenje električnih in

magnetnih veličin

Measurement of electrical and magnetic quantities

oSIST prEN IEC 60688:2021 en,fr,de

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iTeh STANDARD PREVIEW (standards.iteh.ai)

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permission in writing from IEC.

85/748/CDV

COMMITTEE DRAFT FOR VOTE (CDV)

CLOSING DATE FOR VOTING:

2021-04-23

SUPERSEDES DOCUM	ENTS:				
EC TC 85: MEASURING EQUIPMENT FOR ELECTRICAL AND ELECTRI	DMAGNETIC QUANTITIES				
SECRETARIAT:	SECRETARY:				
China	Ms Guiju HAN				
OF INTEREST TO THE FOLLOWING COMMITTEES:	PROPOSED HORIZONTAL STANDARD:				
TC 13,SC 23K,TC 38,TC 66					
	Other TC/SCs are requested to indicate their interest, if any, in this CDV to the secretary.				
FUNCTIONS CONCERNED:					
☐ EMC ☐ ENVIRONMENT	Quality assurance Safety				
SUBMITTED FOR CENELEC PARALLEL VOTING (Standards	☐ NOT SUBMITTED FOR CENELEC PARALLEL VOTING				
Attention IEC-CENELEC parallel voting					
The attention of IEC National Committees, members of 0688:2021 CENELEC, is drawn to the fact that this Committee braft or Vote (CDV) is submitted for parallel voting log/standards/sist/af4f9f6a-5ee6-46a6-a5bc-d59944c954f7/osist-pren-iec-60688-2021 The CENELEC members are invited to vote through the					
CENELEC online voting system.					
	ld not be used for reference numbers				
This document is still under study and subject to change. It shou	· ·				
Recipients of this document are invited to submit, with their which they are aware and to provide supporting documents					
TITLE:					
Electrical measuring transducers for converting AC a signals	and DC electrical quantities to analogue or digital				
PROPOSED STABILITY DATE: 2023					
NOTE FROM TC/SC OFFICERS:					

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INTERNATIONAL ELECTROTECHNICAL COMMISSION

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- International Standard 60688 has been prepared by IEC technical committee 85: Measuring equipment for basic electrical quantities.
- 264 This fourth edition cancels and replaces the third edition published in 2012. It constitutes a technical revision
- This edition includes the following significant technical changes with respect to the previous edition:
- 268 updating normative references;

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- 270 additional requirements for specific transducers used for LV monitoring applications
- 271 creation of interface coding to ease selection by the end-user

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The text of this standard is based on the following documents:

FDIS	Report on voting
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replaced by a revised edition, or

amended.

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		85/XX/FDIS	85/XX/RVD	
274 275 276	Full information on the voting indicated in the a	•	of this standard can be	found in the report on
277	This publication has bee	en drafted in accordance	e with the ISO/IEC Direc	ctives, Part 2.
278	In this standard, the foll	owing print types are us	sed:	
279	 requirements and de 	efinitions: in roman type	•	
280	 NOTES: in smaller roman 	n type;		
281	compliance: in italic	type.		
282 283 284	The committee has dec the stability date indica related to the specific po	ated on the IEC web	site under "http://webst	•
285 286	reconfirmed,withdrawn,			

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The National Committees are requested to note that for this publication the stability date is 2023 (standards.iteh.ai)

THIS TEXT IS INCLUDED FOR THE INFORMATION OF THE NATIONAL COMMITTEES AND WILL BE DELETED AT THE PUBLICATION STAGE OSIST prEN IEC 60688:2021

https://standards.iteh.ai/catalog/standards/sist/af4f9f6a-5ee6-46a6-a5bcd59944c954f7/osist-pren-iec-60688-2021

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296 INTRODUCTION

New transducers can now be equipped with microprocessors that utilise digital data processing, communication methods and auxiliary sensors. This makes them more complex than conventional analogue transducers and gives them considerable added value.

The class index system of classification used in this standard is based upon the IEC 60051 series: *Direct acting indicating analogue electrical measuring instruments and their accessories*. Under this system, the permitted variations of the output signal due to varying influence quantities – ambient temperature, voltage, frequency, etc., – are implicit in the classification.

For those unfamiliar with the class index system, a word of warning is necessary. If, for example, a transducer is classified as Class 1, it does not mean that the error under practical conditions of use will be within ±1 % of the actual value of the output or ±1 % of the full output value. It means that the error should not exceed ±1 % of the fiducial value under closely specified conditions. If the influence quantities are varied between the limits specified by the nominal ranges of use, a variation of amount comparable with the value of the class index may be incurred for each influence quantity.

- The permissible error of a transducer under working conditions is the sum of the permissible intrinsic error and of the permissible variations due to each of the influence quantities. However, the actual error is likely to be much smaller because not all of the influence quantities are likely to be simultaneously at their most unfavourable values and some of the variations may cancel one another. It is important that these facts be taken into consideration when specifying transducers for a particular purpose.
- Furthermore, some of the terms used in this standard are different from those used in IEC 60051 due to the fundamental differences between indicating instruments and measuring transducers.
- 321 All statements of performance are related to the output which is governed by two basic terms:

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- "the nominal value", which may have a positive or a negative sign or both;
- "the span", which is the range of values of the output signal from maximum positive to maximum negative, if appropriate.

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ELECTRICAL MEASURING TRANSDUCERS FOR CONVERTING AC AND DC ELECTRICAL QUANTITIES TO ANALOGUE OR DIGITAL SIGNALS

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Scope

- This International Standard applies to transducers with electrical inputs and outputs for 332 making measurements of AC or DC electrical quantities. The output signal may be in the form 333 of an analogue direct current, an analog direct voltage or in digital form. In this case, that part 334 of the transducer utilized for communication purposes will need to be compatible with the 335 external system. 336
- This standard applies to measuring transducers used for converting following electrical 337 338 quantities such as:
- current, 339
- voltage, 340
- active power, 341
- 342 reactive power,
- power factor, 343
- phase angle, 344 iTeh STANDARD PREVIEW
- frequency, 345
- harmonics or total harmonic (standards.iteh.ai) 346
- 347 apparent power

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- to an output signal. https://standards.iteh.ai/catalog/standards/sist/af4f9f6a-5ee6-46a6-a5bc-348
 - d59944c954f7/osist-pren-iec-60688-2021
- This standard is not applicable for: 349
- instrument transformers that complies with IEC 61869 series; 350
- transmitters for use in industrial process application that complies with IEC 60770 series.; 351
- performance measuring and monitoring devices (PMD) that comply with IEC 61557-12. 352
- Within the measuring range, the output signal is a function of the measurand. An auxiliary 353 supply may be needed. 354
- This standard applies: 355
- a) if the nominal frequency of the input(s) lies between 0 Hz and 1 500 Hz; 356
- b) if a measuring transducer is part of a system for the measurement of a non-electrical 357 quantity, this standard may be applied to the electrical measuring transducer, if it 358 otherwise falls within the scope of this standard; 359
- c) to transducers for use in a variety of applications such as telemetry and process control 360 and in one of a number of defined environments. 361
- This International Standard is intended: 362
- to specify the terminology and definitions relating to transducers whose main application is 363 in industry: 364
- to unify the test methods used in evaluating transducer performance; 365
- to specify accuracy limits and output values for transducers. 366

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2 Normative references

- The following referenced documents are indispensable for the application of this document.
- For dated references, only the edition cited applies. For undated references, the latest edition
- of the referenced document (including any amendments) applies.
- 371 IEC 60051-1:1997, Direct acting indicating analogue electrical measuring instruments and
- their accessories Part 1: Definitions and general requirements common to all parts
- 373 IEC 60068-2-6, Environmental testing Part 2-6: Tests Test Fc: Vibration (sinusoidal)
- 374 IEC 60068-2-27, Environmental testing Part 2-27: Tests Test Ea and guidance: Shock
- 375 IEC 60255-151, Measuring relays and protection equipment Part 151: Functional
- 376 requirements for over/under current protection
- 377 IEC 61010 (all parts), Safety requirements for electrical equipment for measurement, control
- 378 and laboratory use
- 379 IEC 61010-1:2010, Safety requirements for electrical equipment for measurement, control and
- 380 *laboratory use Part 1: General requirements*
- 381 IEC 61010-1:2010/AMD1:2016
- 382 IEC 61010-2-030:2017, Safety requirements for electrical equipment for measurement,
- control, and laboratory use Part 30 Special requirements for testing and measuring circuits
- 384 IEC 61326-1:2020, Electrical equipment for measurement, control and laboratory use EMC
- requirements Part 1. General requirements RD PREVIEW
- 386 IEC 61557-12, Electrical safety in low voltage distribution systems up to 1 000 V AC and 1
- 500 V DC. Equipment for testing, measuring or monitoring of protective measures Part 12:
- 388 Performance measuring and monitoring devices (PMD)₂₀₂₁
- 389 **Terms and definitions** https://standards.iteh.ai/catalog/standards/sist/af4f9f6a-5ee6-46a6-a5bc-d59944c954f7/osist-pren-iec-60688-2021
- For the purpose of this document the following terms and definitions apply:
- 391 3.1 General terms
- 392 **3.1.1**
- 393 (electrical measuring) transducer
- 394 TRD
- device for converting an AC or DC measurand to a direct or alternative current, a direct or
- 396 alternative voltage or a digital signal for measurement purposes
- **397 3.1.2**
- 398 (electrical measuring) transducer type 1
- 399 **TRD1**
- 400 conventional transducer
- NOTE Transducers type 1 are using conventional interface outputs and are generally single-function devices
- 402 3.1.3
- 403 (electrical measuring) transducer type 2
- 404 **TRD2**
- single-function transducer used in LV monitoring applications
- NOTE Transducers type 2 are using specific interface outputs and are generally more accurate
- 407 **3.1.4**
- 408 single-function device
- device performing the measurement of a single electrical quantity (e.g. current, power factor,
- 410 THD, ...) in a single form (e.g. RMS or peak or average, ...) but not both

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- 412 analogue transducer
- device for converting an AC or DC. measurand to a direct or alternative current, a direct or
- 414 alternative voltage for measurement purposes
- 415 **3.1.6**
- 416 digital transducer
- device for converting an AC or DC. measurand to a digital signal for measurement purposes
- 418 3.1.7
- 419 auxiliary supply
- 420 AC or DC electrical supply, other than the measurand, which is necessary for the correct
- 421 operation of the transducer
- 422 **3.1.8**
- 423 auxiliary circuit
- 424 circuit which is usually energized by the auxiliary supply.
- 425 NOTE The auxiliary circuit is sometimes energized by one of the input quantities.
- 426 **3.1.9**
- 427 transducer with offset zero (live zero)
- 428 transducer that gives a predetermined output signal other than zero when the measurand is
- 429 zero
- 430 3.1.10
- 431 transducer with suppressed zero
- 432 transducer for which zero output signal corresponds to a measurand greater than zero
- 433 3.1.11 (standards.iteh.ai)
- 434 total distortion factor
- ratio of the r.m.s. value of the total distortion content to the the r.m.s. value of an alternating quantity
- 436 NOTE The total distortion factor depends on the choice of the fundamental component: If it is not clear from the
- context which one is used an indication should be given pren-iec-60688-2021
- 438 **3.1.12**
- output load (for analogue signals only)
- total resistance of the circuits and apparatus connected externally across the output terminals
- 441 of the transducer
- **3.1.13**
- ripple content (of an analogue output signal)
- with steady-state input conditions, the ratio of the peak-to-peak value of the fluctuating
- component of an analogue output signal, expressed in percentage, to the fiducial value
- 446 **3.1.14**
- 447 output signal
- 448 an analogue or digital representation of the measurand
- **3.1.15**
- 450 output power
- 451 power at the transducer output terminals
- 452 **3.1.16**
- output current (voltage) (for analogue signals only)
- 454 current (voltage) produced by the transducer which is an analogue function of the measurand
- 455 **3.1.17**
- reversible output current (voltage) (for analogue signals only)
- output current (voltage) that reverses polarity in response to a change of sign or direction of
- 458 the measurand

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- 460 measuring element of a transducer
- unit or module of a transducer that converts the measurand, or part of the measurand, into a
- 462 corresponding signal
- 463 **3.1.19**
- 464 single element transducer
- 465 transducer having one measuring element
- 466 3.1.20
- 467 multi-element transducer
- transducer having two or more measuring elements. The signals from the individual elements
- are combined to produce an output signal corresponding to the measurand
- 470 **3.1.21**
- 471 combined transducer
- 472 transducer having two or more measuring circuits for one or more functions
- **473 3.1.22**
- 474 response time
- time from the instant of application of a specified change of the measurand until the output
- signal reaches and remains at its final steady value or within a specified interval centred on
- 477 this value
- 478 **3.1.23**
- 479 compliance voltage
- 480 accuracy limiting output voltage TANDARD PREVIEW
- For variable output load transducers having a current output, the value of the voltage
- appearing across the output (terminals up to which the transducer complies with the
- 483 requirements of this standard
- 484 **3.1.24** oSIST prEN IEC 60688:2021
- (output) series mode interference voltage:
- 486 unwanted alternating voltage appearing in series between the output terminals and the load
- 487 **3.1.25**
- 488 (output) common mode interference voltage
- 489 unwanted alternating voltage that exists between each of the output terminals and a reference
- 490 point
- **491 3.1.26**
- 492 storage conditions
- conditions, defined by means of the ranges of the influence quantities, such as temperature or
- 494 any other special condition, within which the transducer may be stored (non-operating)
- 495 without damage
- 496 3.1.27
- 497 stability
- 498 ability of a transducer to keep its performance characteristics unchanged during a specified
- 499 time, all influence quantities remaining within their specified ranges
- 500 3.1.28
- 501 short-term stability
- stability over a period of 24 h
- 503 3.1.29
- 504 long-term stability
- 505 stability over a period of one year
- 506 3.1.30
- 507 usage group
- group of transducers capable of operating under a specified set of environmental conditions